


<b>Search Notes</b>  	<b>Application/Control No.</b>  10687417	<b>Applicant(s)/Patent Under Reexamination</b>  ESCHBACH ET AL.
	<b>Examiner</b>  Lewis, Cheryl	<b>Art Unit</b>  2167

SEARCHED			
Class	Subclass	Date	Examiner
707	10, 102, and 104.1	1/31/07	CL
709	203	1/31/07	CL
715	500, 526, 781, 784, 786, 803, 804, and 830	1/31/07	CL

SEARCH NOTES		
Search Notes	Date	Examiner
searched WEST US Patents, JPO Abstracts, EPO Abstracts, Derwent Patents, IBM Disclosure, and PLUS search	1/31/07	CL
searched INSPEC database, ACM Library, ProQuest database, and Science Direct database	1/31/07	CL
consulted with primaries C. Huynh, a.u. 2178 and B. Huynh, a.u. 2179, EIC Fast Focus search	1/31/07	CL
inventor name search	1/31/07	CL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same as	above	1/31/0	CL

Date